

<b>Notice of References Cited</b>	Application/Control No. 10/053,765		Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner MARCUS T. RILEY		Art Unit 2625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,705,781 B2	03-2004	Iwazaki, Ryuji	400/62
*	B	US-6,801,962 B2	10-2004	Taniguchi et al.	710/33
*	C	US-7,272,788 B2	09-2007	Anderson et al.	715/210
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
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**NON-PATENT DOCUMENTS**

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	X	

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